

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/665,945	HUAI ET AL.	
Examiner	Art Unit	
Son T. Dinh	2824	

	SEARCHED					
Class	Subclass	Date	Examiner			
365	158	4/23/2006	SD			
365	171	4/23/2006	SD			
365	173	4/23/2006	SD			
360	324.1	4/23/2006	SD			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	4/22/2006	SD
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